

SQ7000+ Multi Function AOI, SPI & CMM

Optical Inspection & Metrology



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Nordson Test & Inspection

Founded in 1954, Nordson Corporation is a market leading industrial technology company with annual revenues of over \$2.1 billion and more than 7,500 employees worldwide.

Nordson Test & Inspection offers its SMT & Semiconductor customers a robust product portfolio, including Acoustic, Optical and both Manual and Automated X-ray Inspection systems, X-ray Component Counting systems and Semiconductor measurement sensors.

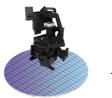
Nordson Test & Inspection is uniquely positioned to serve its customers with best-in-class precision technologies, passionate sales and support teams, global reach, and unmatched consultative applications expertise.





Proprietary Advanced Technology

Optical Inspection & Metrology







WS Products

Improve Your Yields

Semiconductor Metrology Sensors





AMI Products

Qualify Your Design

Acoustic Inspection

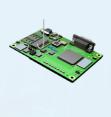




BT Products

Test Your Design

Bondtesters





AXI Products

High Speed High Flexibility

Automated X-ray Inspection





MXI Products

Making the Invisible, Visible

Manual X-ray Inspection





AXM Products

Measuring the Invisible

Automated X-ray Metrology





CC Products

Maximize Efficiency

X-ray Component Counting

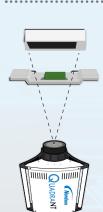




High Speed High Resolution

X-ray Technologies





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Multi Function Advantages

high accuracy and high speed for inspection and metrology.

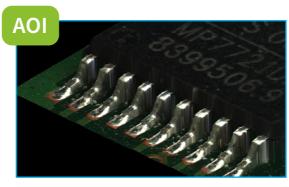
SQ7000+ Multi-Function System with Multi-Reflection Suppression® (MRS®) sensor technology provides the ultimate combination of high resolution,

SQ7000+ with new sensor technology is capable to provide even higher resolution for next generation applications.



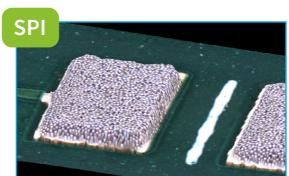
AOI, SPI, CMM IN-LINE

The SQ7000+ remains the only system on the market capable of performing AOI, SPI and CMM in-line.



Automated Optical Inspection (AOI)

The system is specifically designed for high-end applications including advanced packaging, mini-LED, advanced SMT, 008004/0201 SPI, socket metrology and other challenging CMM applications.



Solder Paste Inspection (SPI)

The SQ7000+ offers unmatched accuracy with the revolutionary Multi-Reflection Suppression (MRS) technology by meticulously identifying and rejecting reflections caused by shiny components. Effective suppression of multiple reflections is critical for accurate measurement, making MRS an ideal technology solution for a wide range of applications including those with very high quality requirements.



Coordinate Measuring Machine (CMM)

SQ7000+ utilizes CyberCMM™, a comprehensive software of coordinate measurement tools which provides highly accurate, 100% metrology-grade measurement on all critical points. A fast and easy setup can be performed with the world's first in-line CMM system for programming complex applications.

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Multi-Reflection Suppression®

(MRS®) Sensor Technology

The new, ultra-high resolution 5 micron MRS sensor incorporated into the SQ7000+ is specifically designed for advanced applications with the most demanding requirements.

Reflection based distortions

MRS is designed to Inhibit reflection-based distortions from shiny and specular surfaces Enabling the highest possible inspection accuracy at production speeds.

Unmatched accuracy

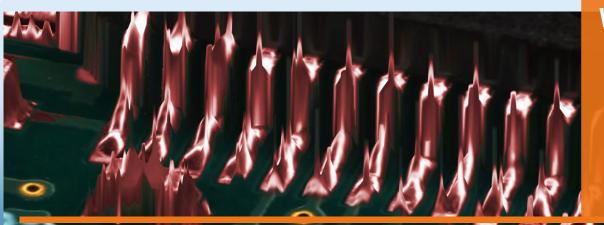
SQ7000+ offers unmatched accuracy with the advanced MRS sensor technology by meticulously identifying and rejecting reflection-based distortions caused by shiny components and surfaces. Effective suppression of multiple reflections is critical for accurate measurements.

The new, ultra-high resolution 5 micron MRS sensor incorporated into the SQ7000+ is specifically designed for advanced applications with the most demanding requirements.



The SQ7000+ is powered by Nordsons' proprietary 3D sensing technology with sophisticated fusing algorithms that enables metrology grade accuracy at production speed. The result is ultra-high quality 3D images, high-speed inspection and metrology, and improved yields and processes.

Even higher resolution for next generation applications



Without MRS



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AOI Software

The multi-award winning SQ7000+ AOI software is a more powerful yet extremely simple software suite designed with an intuitive interface and multi-touch control with 3D image visualization tools.

Ultra-fast programming capabilities

Bring the ease-of-use to a completely new level and significantly speeds setup, simplifies the process, reduces training efforts and minimizes operator interaction – all saving time and cost.

Speed programming and performance with AI² (Autonomous Image Interpretation) technology for set-up in <13 minutes with a data-rich, preloaded library and automated scripts that collect and update models all on their own.

Al² - Enable smarter, faster inspection

With Al², you have the power to inspect the most comprehensive list of features and identify the widest variety of defects. Al² offers precise discrimination with just one panel inspection making it a perfect solution for high-mix and high volume applications.

Al² technology is all about keeping it simple - no parameters to adjust or algorithms to tune. And, you don't need to anticipate defects or pre-define variance either. Al² does it all for you, powered by a data-rich, pre-loaded library and automated scripts that collect and update models all on their own.









Powerful Software Add Ons

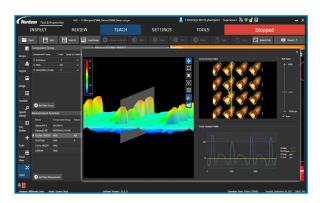
Nordson Software Solutions provide our customers and partners the best addedvalue possible for inspection and measurement in electronics manufacturing.



CMM

Nordson CMM software suite

Nordson CMM's comprehensive software suite of coordinate measurement tools, provides highly accurate, 100% metrology-grade measurement on all critical points much faster than a traditional CMM, including coplanarity, distance, height and datum X, Y to name a few. A fast and easy set-up can be performed with the world's first in-line CMM system for programming complex applications as compared to slow, engineering resource-intensive set-ups that typically requires multiple adjustments with traditional coordinate measurement machines (CMMs).



Measure critical points faster than traditional measurement systems.





Nordson Sight - Fast, scalable SPC software solution

Nordson Sight offers full-fledged machine to factory level SPC capability with powerful historical analysis and reporting tools. The software delivers complete traceability for effective process verification and yield improvement.

Nordson Sight is designed for simple set-up and intuitive use, while simultaneously delivering scalability, fast charting, and an extremely compact database size.

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High End Applications

The SQ7000+ is Nordson's inspection and metrology solution for assembly and process improvement. MRS technology is essential for high-end applications where quality and reliability are critical.

The SQ7000+ inspection and measurement capabilities include:





Fine pitch component • BGA solder ball • Diameter uniformity • BGA coplanarity.





Backlight • Five point & solder paste • Pad gap • Warpage corpenarity • Illumination Intensity • Adhesive squeeze out • Dye chip out.





Pin • True position • Dispensed material • Dispensed patterns.





Tight area • Off water bridging • Jet print paste • Type 4 paste.

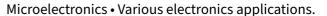
















Tighter tolerance • Higher demand for accuracy • Life critical • Small components, Micro electronics • Conformal coating.





Component verification • Counterfeit part detection • High map • Point cloud output • Adhesive & epoxy.





Metal module cavities • Suberate • Critical • Highly reflective material • Wire bond • Ribbon.





Tuning forks • Connector • True position for key features • True position for key component • High precision placement •



Specifications

| Inspection Capabilities | 5 Micron Ultra-High Resolution MRS Sensor |
|---------------------------------------|--|
| Inspection Speed | 16 cm²/sec (2D+3D) |
| Minimum Component Size | 0201 mm (008004 in.) |
| PCB Size | Minimum: 50 x 50 mm (2 x 2 in.); Maximum: 420 x 320 mm (16.5 x 12.5 in.) |
| Component Height Clearance | Top: 20 mm ; Bottom: 50 mm |
| PCB Thickness | 0.1 - 5 mm |
| Component Types Inspected | Standard SMT (chips, J-lead, gull-wing, BGA, etc.), through-hole, odd-form, clips, connectors, header pins, and more |
| Component Defects | Missing, polarity, tombstone, billboard, flipped, wrong part, gross body and lead damage, and more |
| Solder Joint and Other Defects | Gold finger contamination, excess solder, insufficient solder, bridging, through-hole pins |
| 3D Measurement Inspection | Lifted Lead, package coplanarity, polarity dimple and chamfer identification |
| Measurement Gage R&R | <10% @ ±3σ (±30 μm process tolerance) |
| Z Height Accuracy & Measurement Range | Z Height Accuracy: 0.5 μm on certification target • Z Height Measurement Range: 400 μm at spec, 2.4 mm capability |

| CMM Capabilities | |
|-----------------------------------|--|
| Accuracy & Resolution XY / Z | Accuracy XY / Z: 2 μm / 0.5 μm • Resolution XY / Z: 5 μm / 0.1 μm |
| Maximum Weight | 10 kg |
| Min./ Max. Feature Height | Min. 10 μm ; Max. 400 μm at spec, 2.4 mm capability |
| Maximum Feature Size | 420 x 320 mm (16.5 x 12.5 in.) |
| Carrier Thickness | 0.1 - 5 mm |
| Coordinate Measurement Capability | Line / Distance / X,Y / Mid Line, Inter Point / Regression Shifted, Datum X,Y / LSF X,Y Offset, X,Y Offset / Value / Location / List of X,Y Values, Height / Local Height / Regression / Radius, Coplanarity/ Distance to plane / 2nd Order fitting, Differ- ence / Absolute / 2sqrt / VC, Max / Min / Ave / Sigma / Plus / Minus / Multiple |

| Vision System & Technology | |
|----------------------------|--|
| Imagers | Multi-3D sensors |
| Resolution | 5 μm |
| Field of View (FOV) | 25 x 25 mm |
| Image Processing | Autonomous Image Interpretation (AI ²) Technology, Coplanarity and Lead Measurement |
| Programming Time | <13 minutes (for established libraries) |
| CAD Import | Any column-separated text file with ref designator, XY, Angle, Part no info; Valor process preparation |

| System Specifications | | |
|-----------------------------|---|--|
| Machine Interface | SMEMA, RS232 and Ethernet | |
| Power Requirements | 100-120 VAC or 220-240 VAC (±10%), 50/60 hz, 10-15 amps | |
| Compressed Air Requirements | 5.6 Kgf/cm² to 7.0 Kgf/cm² (80 to 100 psi @ 4 cfm) | |
| System Dimensions | 135 x 148 x 175 cm (W x D x H) | |
| Weight | 2,350kg (5180 lbs.) | |

| Options | |
|---------|--|
| | Barcode Reader, Rework station, Nordson Sight SPC Software, Alignment Target |
| | SO3000™, SO3000™ X (Large Board), SO3000™ D (Dual Lane), and SO3000™ DD (Dual Lane - Dual Sensor) models available |

For more information, speak with your Nordson representative or contact your Nordson regional office

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